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PATENT- AF RESPONSE UNDER 37 C.F.R. 1.116 **EXPEDITED PROCEDURE EXAMINING GROUP 2826** 

CERTIFICATE OF MAILING (37 C.F.R. 1.8a)

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## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:

Bin Yu, et al.

Serial No.:

10/044,493

Art Unit: 2826

Filed:

January 11, 2002

Confirmation No.: 9266

Title:

SEMICONDUCTOR DEVICE WITH SILICIDE

SOURCE/DRAIN AND HIGH-K DIELECTRIC

Examiner:

Kevin V. Quinto

Docket No.:

G0615

RESPONSE UNDER 37 C.F.R. 1.116 TO OFFICE ACTION DATED DECEMBER 4, 2002

**Box AF** 

Commissioner for Patents U.S. Patent and Trademark Office Washington, D.C. 20231

Sir:

This reply is filed in response to the Office action dated December 4, 2002. It is believed that the reply raises no new issues, does not require an additional search and/or

## BEST AVAILABLE COPY

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A marked version of the amended claim appears below (deletions bracketed and struck through and additions underlined):

20. (amended) <u>A</u> [<del>The</del>] semiconductor device [<del>according to claim 1,</del>] <u>comprising:</u>

a source and a drain, said source and drain consisting essentially of silicide;

a semiconductor body disposed between the source and the drain, wherein a source/body junction is defined by silicide material of the source and semiconductor material of the body and a drain/body junction is defined by silicide material of the drain and semiconductor material of the body;

a gate electrode disposed over the body and defining a channel interposed between the source and the drain; and

<u>a gate dielectric made from a high-K material and separating the gate electrode</u> <u>and the body</u>.